SY89874U

2.5 GHz, Any Differential In-to-LVPECL, Programmable Clock Divider/Fanout Buffer with Internal Termination

Features

- Integrated Programmable Clock Divider and 1:2 Fanout Buffer
- Guaranteed AC Performance over Temperature and Voltage:
 - >2.5 GHz f_{MAX}
 - <250 ps t_r/t_f
 - <15 ps Within-Device Skew
- · Low Jitter Design:
 - <10 ps_{PP} Total Jitter
 - <1 ps_{RMS} Cycle-to-Cycle Jitter
- Unique Input Termination and V_T Pin for DC-Coupled and AC-Coupled Inputs; CML, PECL, LVDS, and HSTL
- · TTL/CMOS Inputs for Select and Reset
- 100KEP-Compatible LVPECL Outputs
- · Parallel Programming Capability
- Programmable Divider Ratios of 1, 2, 4, 8, and 16
- · Low-Voltage Operation: 2.5V or 3.3V
- · Output Disable Function
- –40°C to +85°C Temperature Range
- Available in 16-Pin (3 mm x 3 mm) QFN Package

Applications

- · SONET/SDH Line Cards
- Transponders
- · High-End Multiprocessor Sensors

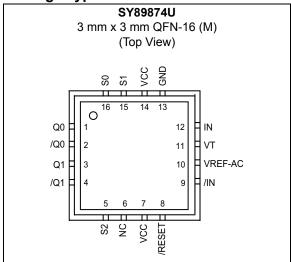
General Description

This low-skew, low-jitter device is capable of accepting a high-speed (e.g., 622 MHz or higher) CML, LVPECL, LVDS, or HSTL clock input signal and dividing down the frequency using a programmable divider ratio to create a frequency-locked, lower speed version of the input clock. Available divider ratios are 2, 4, 8, and 16, or straight pass-through. In a typical 622 MHz clock system this would provide availability of 311 MHz, 155 MHz, 77 MHz, or 38 MHz auxiliary clock components.

The differential input buffer has a unique internal termination design that allows access to the termination network through a $V_{\rm T}$ pin. This feature allows the device to easily interface to different logic standards. A $V_{\rm REF-AC}$ reference is included for AC-coupled applications.

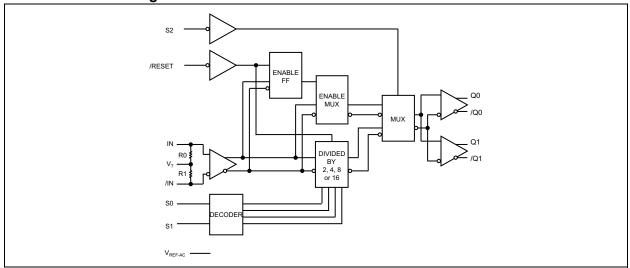
The /RESET input asynchronously resets the divider. In the pass-through function (divide by 1) the /RESET synchronously enables or disables the outputs on the next falling edge of IN (rising edge of /IN).

Package Type

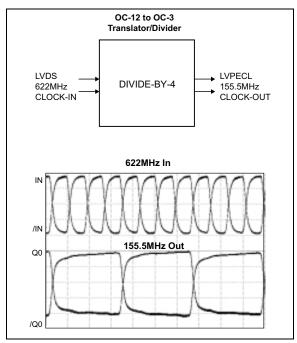


United States Patent No. RE44,134

Functional Block Diagram



Typical Performance



TRUTH TABLE

/RESET	S2	S1	S0	Outputs
1	0	Х	X Reference clock (pass-through)	
1	1	0	0	Reference clock ÷ 2
1	1	0	1	Reference clock ÷ 4
1	1	1	0	Reference clock ÷ 8
1	1	1	1	Reference clock ÷ 16
0	1	Х	X Q = Low, /Q = High clock disable	

1.0 ELECTRICAL CHARACTERISTICS

Absolute Maximum Ratings †

Supply Voltage (V _{CC})	
Input Voltage (V _{IN})	–0.5V to V _{CC} + 0.3V
ECL Output Current	
Continuous	
Surge	100 mA
Input Current IN, /IN (I _{IN})	
V _T Current (I _{VT})	±100 mA
V _{REF-AC} Sink/Source Current (I _{VREF-AC}) (Note 1)	±2 mA
Operating Ratings ††	
Supply Voltage (V _{CC})	+3.3V ±10% or +2.5V ±5%

[†] Notice: Permanent device damage may occur if absolute maximum ratings are exceeded. This is a stress rating only and functional operation is not implied at conditions other than those detailed in the operational sections of this data sheet. Exposure to absolute maximum ratings conditions for extended periods may affect device reliability.

^{††} Notice: The data sheet limits are not guaranteed if the device is operated beyond the operating ratings.

Note 1: Due to the limited drive capability, use for input of the same package only.

DC ELECTRICAL CHARACTERISTICS (Note 1)

Electrical Characteristics: $T_A = -40$ °C to +85°C, unless otherwise stated.

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions
Power Supply	V _{CC}	2.375	_	3.63	V	_
Power Supply Current	I _{CC}	1	50	75	mA	No load, max. V _{CC}
Differential Input Resistance (IN-to-/IN)	R _{IN}	90	100	110	Ω	
Input High Voltage (IN, /IN)	V _{IH}	0.1	_	V _{CC} + 0.3	V	Note 2
Input Low Voltage (IN, /IN)	V_{IL}	-0.3	_	V _{IH} – 0.1	V	Note 2
Input Voltage Swing	V_{IN}	0.1	_	V _{CC}	V	Note 2, Note 3
Different Input Voltage Swing	V _{DIFF_IN}	0.2	_	_	V	Note 2, Note 3, Note 4
Input Current (IN, /IN)	I _{IN}		_	45	mA	Note 2
Reference Voltage	V _{REF-AC}	V _{CC} – 1.525	V _{CC} – 1.425	V _{CC} – 1.325	V	Note 5

- **Note 1:** The circuit is designed to meet the DC specifications shown in the above table after thermal equilibrium has been established.
 - 2: Due to the internal termination (see Input Buffer Structure), the input current depends on the applied voltages at IN, /IN, and V_T inputs. Do not apply a combination of voltages that causes the input current to exceed the maximum limit. Performance might be impacted if the differential inputs are driven single-ended.
 - 3: See Timing Diagram for V_{IN} definition. V_{IN} (maximum) is specified when V_{IN} is floating.
 - 4: See Definition of Single-Ended and Differential Swing section for V_{DIFF} definition.
 - **5:** Operating using V_{REF-AC} is limited to AC-coupled PECL or CML applications only. Connect directly to the V_T pin.

LVPECL (100KEP) DC ELECTRICAL CHARACTERISTICS

Electrical Characteristics: V_{CC} = 3.3V ±10% or 2.5V ±5%; T_A = -40°C to +85°C, R_L = 50 Ω to V_{CC} - 2V, unless otherwise stated. Note 1

Parameter	Symbol	Min.	Тур.	Max.	Units	Condition
Output High Voltage	V _{OH}	V _{CC} – 1.145	V _{CC} – 1.020	V _{CC} – 0.895	V	_
Output Low Voltage	V _{OL}	V _{CC} – 1.945	V _{CC} – 1.820	V _{CC} – 1.695	V	_
Output Voltage Swing	V _{OUT}	550	800	1050	mV	_
Differential Output Voltage Swing	V _{DIFF_OUT}	1.10	1.60	2.10	٧	_

Note 1: The circuit is designed to meet the DC specifications shown in the LVPECL (100KEP) Electrical Characteristics table after thermal equilibrium has been established.

LVTTL/CMOS DC ELECTRICAL CHARACTERISTICS

Electrical Characteristics: $V_{CC} = 3.3V \pm 10\%$ or 2.5V $\pm 5\%$; $T_A = -40^{\circ}$ C to $\pm 85^{\circ}$ C, unless otherwise stated. Note 1

Parameter	Symbol	Min.	Тур.	Max.	Units	Condition
Input High Voltage	V _{IH}	2.0	_	_	V	_
Input Low Voltage	V_{IL}	_	_	0.8	V	_
Input High Current	I _{IH}	-125	_	20	μΑ	_
Input Low Current	I _{IL}	-300	_	_	μA	_

Note 1: The circuit is designed to meet the DC specifications shown in the LVTTL/CMOS Electrical Characteristics table after thermal equilibrium has been established.

AC ELECTRICAL CHARACTERISTICS

Electrical Characteristics: V_{CC} = 3.3V ±10% or 2.5V ±5%; T_A = -40°C to +85°C, R_L = 50 Ω to V_{CC} - 2V, unless otherwise stated. Note 1, Note 2

Parameter	Symbol	Min.	Тур.	Max.	Units	Condition	
Maximum Output Toggle Frequency	f _{MAX}	2.5		_	GHz	Output swing ≥400 mV	
Maximum Input Frequency		3.2	_	_		Divide by 2, 4, 8, 16	
Differential Propagation	+	540	650	790	no	Input swing <400 mV	
Delay IN-to-Q	t _{PD}	480	600	730	ps	Input swing ≥400 mV	
Within Device Skew (Differential) Q0 - Q1	4	_	7	15	- ps	Note 3	
Part-to-Part Skew (Differential)	t _{SKEW}	_	_	250			
Reset Recovery Time	t _{RR}	600	_	_	ps	Note 4	
Cycle-to-Cycle Jitter		_	_	1	ps _{RMS}	Note 5	
Total Jitter		_	_	10	ps _{PP}	Note 6	
Additive Phase Jitter	t _{JITTER}	_	- 81 — fs _{RM}		fs _{RMS}	Integration Range: 12 kHz to 20 MHz, Carrier: 622.08 MHz, T _A = +25°C	
Rise/Fall Time (20% to 80%)	t _r /t _f	70	150	250	ps	_	

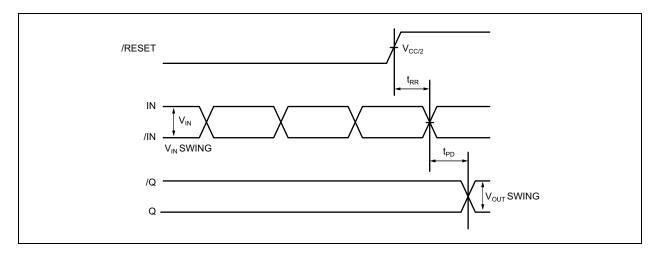
- **Note 1:** Measured with 400 mV signal, 50% duty cycle, all outputs loaded with 50Ω to V_{CC} 2V, unless otherwise stated.
 - 2: Specification for packaged product only.
 - 3: Skew is measured between outputs under identical transitions.
 - 4: See the Timing Diagram section.
 - 5: Cycle-to-cycle jitter definition: The variation in period between adjacent cycles over a random sample of adjacent cycle pairs. $t_{JITTER\ CC} = t_n t_{n+1}$, where "t" is the time between rising edges of the output signal.
 - 6: Total jitter definition: With an ideal clock input, of frequency ≤f_{MAX} (device), no more than one output edge in 10¹² output edges will deviate by more than the specified peak-to-peak jitter value.

TEMPERATURE SPECIFICATIONS

Parameters	Sym.	Min.	Тур.	Max.	Units	Conditions		
Temperature Ranges								
Operating Ambient Temperature Range	T _A	-40	_	+85	°C	_		
Lead Temperature	_	_	_	+260	°C	Soldering, 20 sec.		
Storage Temperature Range	T _S	-65	_	+150	°C	_		
Package Thermal Resistances	Package Thermal Resistances							
	θ_{JA}	_	60	_	°C/W	Still-air		
Thermal Resistance, 3x3 QFN-16Ld	θ_{JA}	_	54	_	°C/W	500 lpfm		
	ψ_{JB}	_	32	_	°C/W	Junction-to-board, Note 1		

Note 1: Junction-to-board resistance assumes exposed pad is soldered (or equivalent) to the device's most negative potential on the PCB.

Timing Diagram



2.0 TYPICAL PERFORMANCE CURVES

Note: The graphs and tables provided following this note are a statistical summary based on a limited number of samples and are provided for informational purposes only. The performance characteristics listed herein are not tested or guaranteed. In some graphs or tables, the data presented may be outside the specified operating range (e.g., outside specified power supply range) and therefore outside the warranted range.

 V_{CC} = 3.3V, V_{IN} = 400 mV, T_A = +25°C, unless otherwise stated.

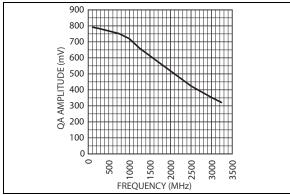


FIGURE 2-1: QA Output Amplitude vs. Frequency.

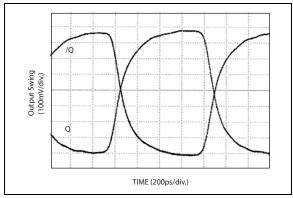


FIGURE 2-4: 622 MHz Output.

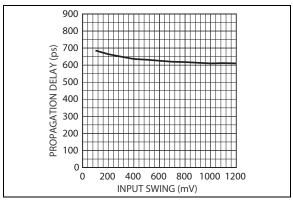


FIGURE 2-2: IN-to-Q Propagation Delay vs. Input Swing.

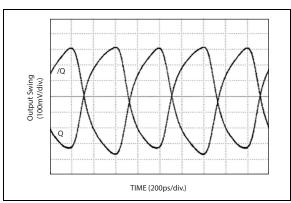


FIGURE 2-5: 1.25 GHz Output.

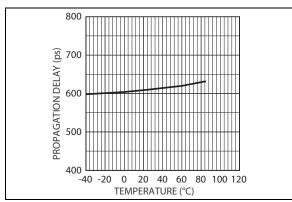


FIGURE 2-3: IN-to-Q Propagation Delay vs. Temperature.

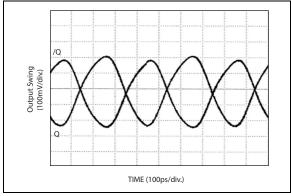


FIGURE 2-6: 2.5 GHz Output.

3.0 ADDITIVE PHASE NOISE PLOT

Additive jitter is defined as the RMS Jitter of the device added to the input signal and is calculated in Equation 3-1.

EQUATION 3-1:

$$DeviceAdditiveJitter = \sqrt{OutputRMSJitter^2 - InputRMSJitter^2}$$

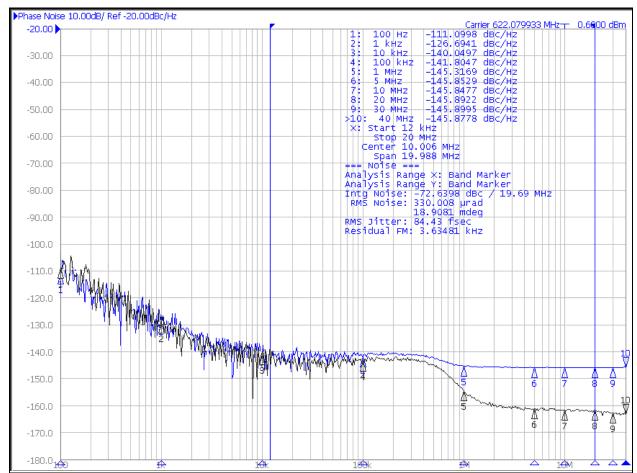


FIGURE 3-1: Integrated Phase Noise Plot of SY89874U (Device) and the Source (Input Signal).

From the plot shown in Figure 3-1, the device additive jitter can be calculated as follows.

EQUATION 3-2:

CalculatedAdditiveJitter =
$$\sqrt{84.43^2 - 23.07^2}$$
 = 81.21fs

4.0 PIN DESCRIPTIONS

The descriptions of the pins are listed in Table 4-1.

TABLE 4-1: PIN FUNCTION TABLE

Pin Number	Symbol	Description
12, 9	IN, /IN	Differential input. Internal 50Ω termination resistors to V_T input. Flexible input accepts any differential input. See the Input Interface Applications section.
1, 2, 3, 4	Q0, /Q0 Q1, /Q1	Differential buffered LVPECL Outputs. Divided by 1, 2, 4, 8, or 16. See Truth Table. Unused PECL outputs may be left floating with no impact on jitter performance.
16, 15, 5	S0, S1, S2	Select pins. See Truth Table. LVTTL/CMOS logic levels. Internal 25 k Ω pull-up resistor. Logic high if left unconnected (divided by 16 mode). Input threshold is $V_{CC}/2$.
6	NC	No connect.
8	/RESET /DISABLE	LVTTL/CMOS logic levels. Internal 25 k Ω pull-up resistor. Logic high if left unconnected. Apply low to reset the divider (divided by 2, 4, 8, or 16 mode). Also acts as a synchronous disable/enable function. The reset and disable function occurs on the next high-to-low clock input transition. Input threshold is $V_{\rm CC}/2$.
10	V _{REF-AC}	Reference voltage. Equal to V_{CC} – 1.4V (approximately). Used for AC-coupled applications only. Decouple the V_{REF-AC} pin with a 0.01 μ F capacitor. See the Input Interface Applications section.
11	V_{T}	Termination center tap. For CML or LVDS inputs, leave this floating. Otherwise, see the figures within the Input Interface Applications section.
7, 14	V _{CC}	Positive power supply. Bypass with 0.1 μF//0.01 μF low-ESR capacitor.
13	GND, Exposed Pad	Ground. Exposed pad must be connected to a ground plane that is the same potential as the ground pin.

5.0 DEFINITION OF SINGLE-ENDED AND DIFFERENTIAL SWING

Single-ended swing is defined as the amplitude of the signal when driven differentially. Differential swing is defined as IN - /IN (or Q - /Q).

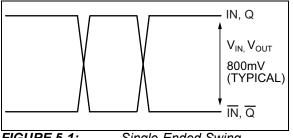


FIGURE 5-1: Single-Ended Swing.

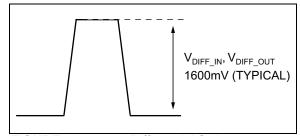


FIGURE 5-2: Differential Swing.

6.0 INPUT BUFFER STRUCTURE

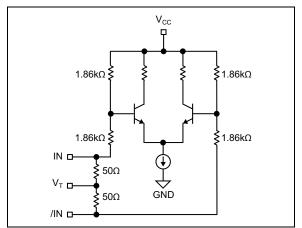


FIGURE 6-1: Simplified Differential Input Stage.

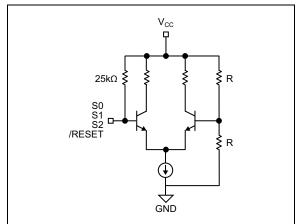


FIGURE 6-2: Simplified LVTTL/CMOS Input Stage.

7.0 INPUT INTERFACE APPLICATIONS

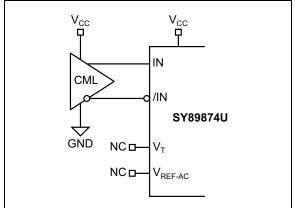


FIGURE 7-1: DC-Coupled CML Input Interface.

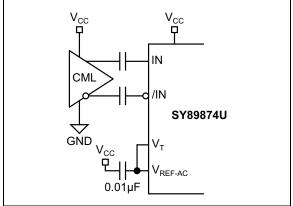


FIGURE 7-2: AC-Coupled CML Input Interface.

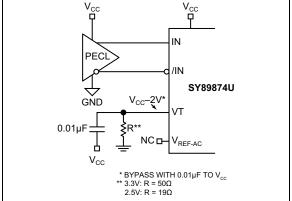


FIGURE 7-3: DC-Coupled PECL Input Interface.

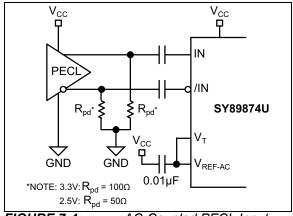


FIGURE 7-4: AC-Coupled PECL Input Interface.

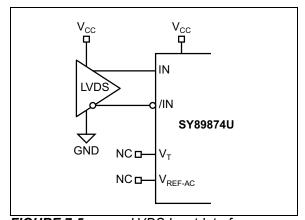


FIGURE 7-5: LVDS Input Interface.

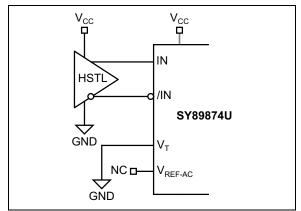


FIGURE 7-6: HSTL Input Interface.

8.0 LVPECL OUTPUT TERMINATION RECOMMENDATIONS

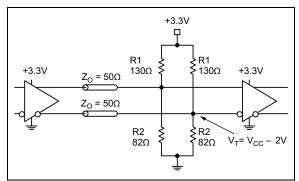


FIGURE 8-1: Parallel Termination Thevenin Equivalent.

For Figure 8-1, note that for +2.5V systems: R1 = 250Ω , R2 = 62.5Ω .

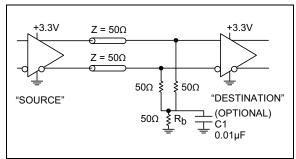


FIGURE 8-2: Three-Resistor "Y Termination".

For Figure 8-2, note that this is a power-saving alternative to Thevenin termination. Place termination resistors as close to destination inputs as possible. The R_b resistor sets the DC bias voltage, equal to V_T . For +3.3V systems R_b = 46 Ω to 50Ω . For +2.5V systems, R_b = 39Ω . C1 is an optional bypass capacitor intended to compensate for any t_r/t_f mismatches.

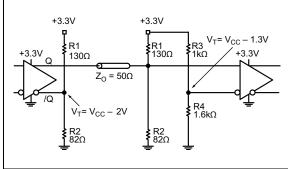


FIGURE 8-3: Terminating Unused I/O.

For Figure 8-3, note that the unused output (/Q) must be terminated to balance the output. For +2.5V systems: R1 = 250Ω , R2 = 62.5Ω , R3 = $1.25 \text{ k}\Omega$, R4 = $1.2 \text{ k}\Omega$.

9.0 PACKAGING INFORMATION

9.1 Package Marking Information

16-Lead QFN*



Example



Legend: XX...X Product code or customer-specific information

Y Year code (last digit of calendar year)
YY Year code (last 2 digits of calendar year)
WW Week code (week of January 1 is week '01')

NNN Alphanumeric traceability code

(e3) Pb-free JEDEC® designator for Matte Tin (Sn)

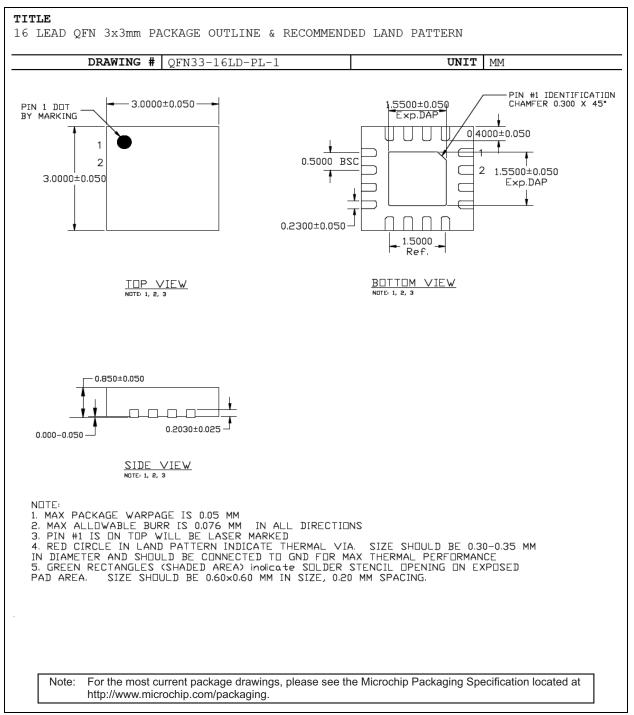
This package is Pb-free. The Pb-free JEDEC designator ((e3)) can be found on the outer packaging for this package.

•, ▲, ▼ Pin one index is identified by a dot, delta up, or delta down (triangle mark).

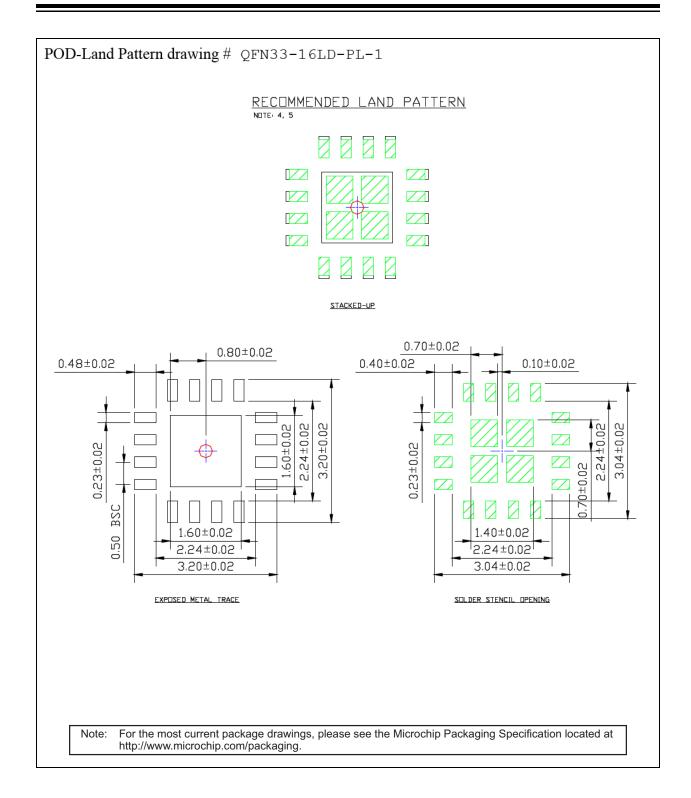
Note: In the event the full Microchip part number cannot be marked on one line, it will be carried over to the next line, thus limiting the number of available characters for customer-specific information. Package may or may not include the corporate logo.

Underbar () and/or Overbar () symbol may not be to scale.

16-Lead 3 mm x 3 mm QFN Package Outline and Recommended Land Pattern



Note: Package meets Level 2 moisture sensitivity classification and is shipped in dry-pack. Exposed pads must be soldered to a ground for proper thermal management.



SY89874U

NOTES:

APPENDIX A: REVISION HISTORY

Revision A (October 2018)

- Converted Micrel document SY89874U to Microchip data sheet template DS20006108A.
- · Minor text changes throughout.
- Added information about Additive Phase Jitter in AC Electrical Characteristics table and Additive Phase Noise Plot section.

Revision B (November 2018)

 Corrected units of measurement for Additive Phase Jitter in AC Electrical Characteristics from ps_{RMS} to fs_{RMS}.

SY89874U

NOTES:

PRODUCT IDENTIFICATION SYSTEM

To order or obtain information, e.g., on pricing or delivery, contact your local Microchip representative or sales office.

PART NO.	v	v v	-YY	Example	s:	
Device	X Input Pa Voltage	X X 	- <u>XX</u> Tape and Reel	a) SY898	74UMG:	SY89874, 2.5V/3.3V Input Voltage, 3 mm x 3 mm 16-Lead QFN, -40°C to +85°C Temperature Range, 100/Tube
Device:	SY89874:	2.5GHz, Any Differential Ir Programmable Clock Divi with Internal Termination		b) SY898	74UMG-TR:	SY89874, 2.5V/3.3V Input Voltage, 3 mm x 3 mm 16-Lead QFN, -40°C to +85°C Temperature Range,
Input Voltage:	U =	2.5V/3.3V		Note 1:	Tana and Day	1,000/Reel
Package:	M =	3 mm x 3 mm QFN-16		Note 1:	catalog part r identifier is us	el identifier only appears in the number description. This sed for ordering purposes and on the device package. Check
Temperature Range:	G =	–40°C to 85°C (NiPdAu Lea	d-Free)			rochip Sales Office for package th the Tape and Reel option.
Special Processing:	 <blank> = TR =</blank>	100/Tube 1,000/Reel				

SY89874U

NOTES:

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